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December 2015

FDPC8014AS

PowerTrench® Power Clip 25V Asymmetric Dual N-Channel MOSFET

Features

Q1: N-Channel

- \blacksquare Max $r_{DS(on)}$ = 3.8 m Ω at V_{GS} = 10 V, I_{D} = 20 A
- \blacksquare Max $r_{DS(on)}$ = 4.7 m Ω at V_{GS} = 4.5 V, I_D = 18 A

Q2: N-Channel

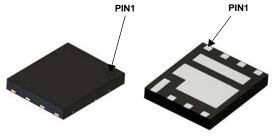
- Max $r_{DS(on)} = 1.0 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 40 \text{ A}$
- \blacksquare Max $\rm r_{DS(on)}$ = 1.2 m Ω at $\rm V_{GS}$ = 4.5 V, $\rm I_D$ = 37 A
- Low Inductance Packaging Shortens Rise/fall Times, Resulting in Lower Switching Losses
- MOSFET Integration Enables Optimum Layout for Lower Circuit Inductance and Reduced Switch Node Ringing
- RoHS Compliant

General Description

This device includes two specialized N-Channel MOSFETs in a dual package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

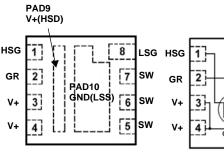
Applications

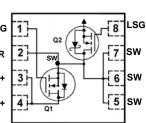
- Computing
- Communications
- General Purpose Point of Load



Power Clip 5X6







Pin	Name Description Pin Name Descrip		Description	Pin	Name	Description		
1	HSG	High Side Gate	3,4,9	V+(HSD)	High Side Drain	8	LSG	Low Side Gate
2	GR	Gate Return	5,6,7	SW	Switching Node, Low Side Drain	10	GND(LSS)	Low Side Source

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Bottom

Symbol	Parameter			Q1	Q2	Units
V_{DS}	Drain to Source Voltage			25 ^{Note5}	25	V
V_{GS}	Gate to Source Voltage			±12	±12	V
	Drain Current -Continuous	T _C = 25 °C	(Note 6)	59	159	
	-Continuous	T _C = 100 °C	(Note 6)	37	100	
I _D	-Continuous	T _A = 25 °C		20 ^{Note1a}	40 ^{Note1b}	A
	-Pulsed		(Note 4)	266	1116	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	73	294	mJ
Б	Power Dissipation for Single Operation $T_C = 20$		T _C = 25 °C	21	37	10/
P_{D}	Power Dissipation for Single Operation		T _A = 25 °C	2.1 ^{Note1a}	25 ±12 159 100 40 ^{Note1b} 1116 294 37 2.3 ^{Note1b}	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range)		-55 to	+150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	6.0	3.3	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	60 ^{Note1a}	55 ^{Note1b}	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	130 ^{Note1c}	120 ^{Note1d}	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPC8014AS	FDPC8014AS	Power Clip 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Туре	Min.	Тур.	Max.	Units
Off Chara	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	Q1	25			V
DVDSS	Dialii to Source Breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	Q2	25			V
ΔBV_{DSS}	Breakdown Voltage Temperature	$I_D = 250 \mu A$, referenced to 25 °C	Q1		24		mV/°C
ΔT_{J}	Coefficient	I_D = 10 mA, referenced to 25 °C	Q2		25		IIIV/ C
	Zoro Coto Voltago Proin Current	V _{DS} = 20 V, V _{GS} = 0 V	Q1			1	μΑ
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	Q2			500	μΑ
	Gate to Source Leakage Current,	V _{GS} = 12 V/-8 V, V _{DS} = 0 V	Q1			±100	nA
I _{GSS}	Forward	$V_{GS} = 12 \text{ V/-8 V}, V_{DS} = 0 \text{ V}$	Q2			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$	Q1 Q2	0.8 1.0	1.3 1.5	2.5 3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.I}}$	Gate to Source Threshold Voltage	$I_D = 250 \mu A$, referenced to 25 °C	Q1		-4		mV/°C
ΔT_J	Temperature Coefficient	I _D = 10 mA, referenced to 25 °C	Q2		-3		, 0
	Drain to Source On Resistance	V _{GS} = 10V, I _D = 20 A			2.9	3.8	
		$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$	Q1		3.6	4.7	
r		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 \text{ °C}$			3.9	5.3	mΩ
r _{DS(on)}		V _{GS} = 10V, I _D = 40 A			0.75	1.0	1115.2
		$V_{GS} = 4.5 \text{ V}, I_D = 37 \text{ A}$	Q2		0.9	1.2	
		$V_{GS} = 10 \text{ V}, I_D = 40 \text{ A}, T_J = 125 ^{\circ}\text{C}$			1.0	1.5	
a	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 20 \text{ A}$	Q1		182		S
9 _{FS}	rorward transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 40 \text{ A}$	Q2		296		3

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1:	Q1 Q2		1695 6985	2375 9780	pF
C _{oss}	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$ $Q2:$	Q1 Q2		495 2170	710 3040	pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2		54 172	100 245	pF
R _g	Gate Resistance		Q1 Q2	0.1 0.1	0.4 0.4	1.2 1.2	Ω

Switching Characteristics

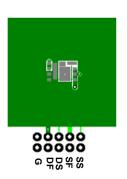
t _{d(on)}	Turn-On Delay Time			Q1 Q2	8 16	16 29	ns
t _r	Rise Time	Q1: V _{DD} = 13 V, I _D = 20	O A, $R_{GEN} = 6 \Omega$	Q1 Q2	2 6	10 12	ns
t _{d(off)}	Turn-Off Delay Time	Q2:) A Roey = 6.0	Q1 Q2	24 48	38 76	ns
t _f	Fall Time		$V_{DD} = 13 \text{ V}, I_{D} = 40 \text{ A}, R_{GEN} = 6 \Omega$		2 5	10 10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	Q1	Q1 Q2	25 97	35 135	nC
Qg	Total Gate Charge	V _{GS} = 0 V to 4.5 V		Q1 Q2	11 44	16 62	nC
Q _{gs}	Gate to Source Gate Charge		Q2 V _{DD} = 13 V, I _D	Q1 Q2	3.4 14		nC
Q _{gd}	Gate to Drain "Miller" Charge		= 40 A	Q1 Q2	2.2 9		nC

Electrical Characteristics T_J = 25 °C unless otherwise noted.

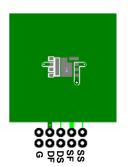
Symbol Parameter		Test Conditions	Type	Min.	Тур.	Max.	Units
Drain-Soເ	rce Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 20 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 40 \text{ A}$ (Note 2)	Q1 Q2		0.8 0.8	1.2 1.2	V
I _S	Diode continuous forward current	T _ 25 °C	Q1 Q2		59 159		Α
I _{S,Pulse}	Diode pulse current	-T _C = 25 °C	Q1 Q2		266 1116		А
t _{rr}	Reverse Recovery Time	Q1 I _F = 20 A, di/dt = 100 A/μs	Q1 Q2		25 44	40 70	ns
Q _{rr}	Reverse Recovery Charge	Q2 $I_F = 40 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$	Q1 Q2		10 78	20 125	nC

Notes

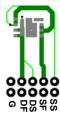
1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



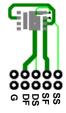
a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 55 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 130 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

- 2 Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. Q1 : E_{AS} of 73 mJ is based on starting $T_J = 25$ ^{o}C ; N-ch: L = 3 mH, $I_{AS} = 7$ A, $V_{DD} = 30$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 24$ A. Q2: E_{AS} of 294 mJ is based on starting $T_J = 25$ ^{o}C ; N-ch: L = 3 mH, $I_{AS} = 14$ A, $V_{DD} = 25$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 46$ A.
- 4. Pulsed Id please refer to Fig 11 and Fig 24 SOA graph for more details.
- 5. The continuous V_{DS} rating is 25 V; However, a pulse of 30 V peak voltage for no longer than 100 ns duration at 600 KHz frequency can be applied.
- 6. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted.

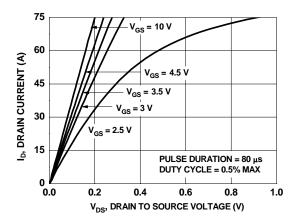


Figure 1. On Region Characteristics

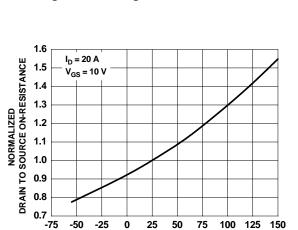


Figure 3. Normalized On Resistance vs. Junction Temperature

-25 0 25 50 T_J, JUNCTION TEMPERATURE (°C)

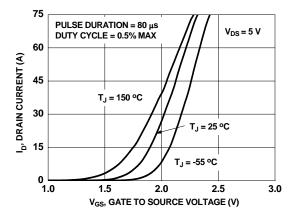


Figure 5. Transfer Characteristics

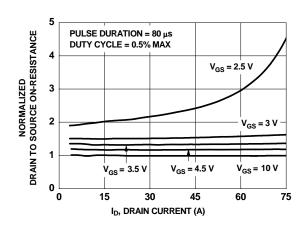


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

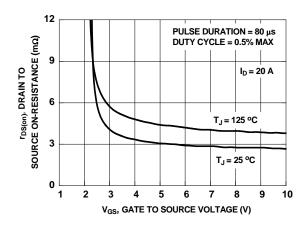


Figure 4. On-Resistance vs. Gate to Source Voltage

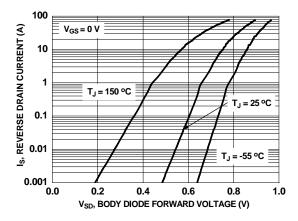


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

-75

Typical Characteristics (Q1 N-Channel) $T_J = 25$ °C unless otherwise noted.

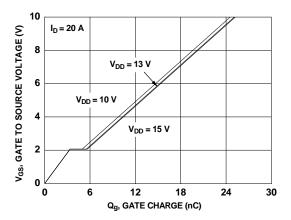


Figure 7. Gate Charge Characteristics

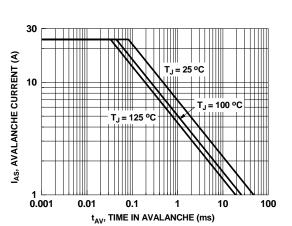


Figure 9. Unclamped Inductive Switching Capability

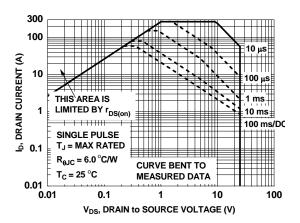


Figure 11. Forward Bias Safe Operating Area

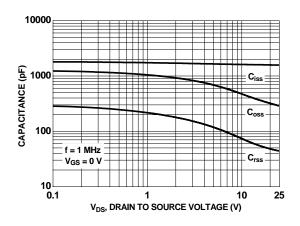


Figure 8. Capacitance vs. Drain to Source Voltage

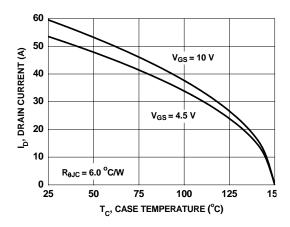


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

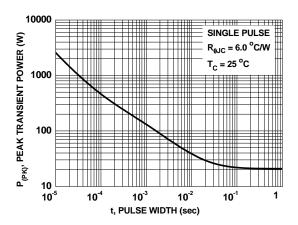


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) $T_J = 25$ °C unless otherwise noted.

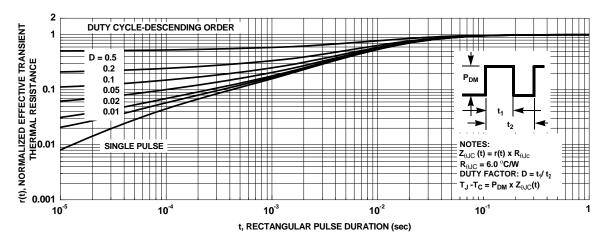


Figure 13. Junction-to-Case Transient Thermal Response Curve

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unless otherwise noted.

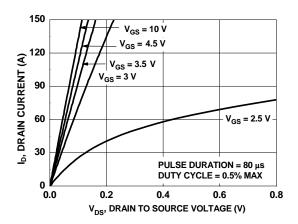


Figure 14. On- Region Characteristics

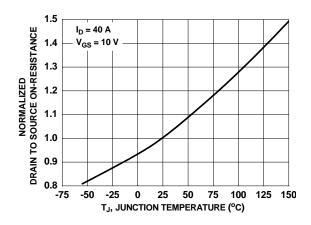


Figure 16. Normalized On-Resistance vs. Junction Temperature

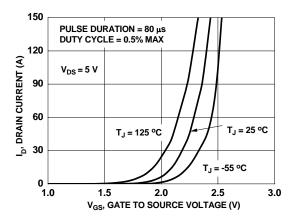


Figure 18. Transfer Characteristics

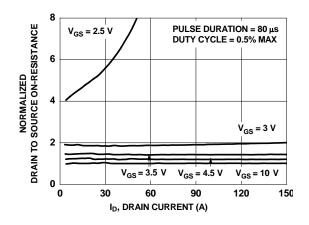


Figure 15. Normalized on-Resistance vs. Drain Current and Gate Voltage

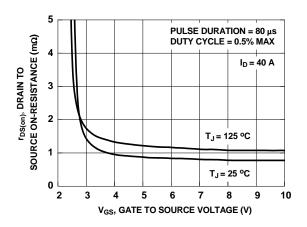


Figure 17. On-Resistance vs. Gate to Source Voltage

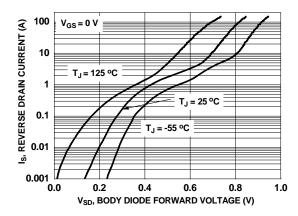


Figure 19. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics (Q2 N-Channel) T_{.I} = 25°C unless otherwise noted.

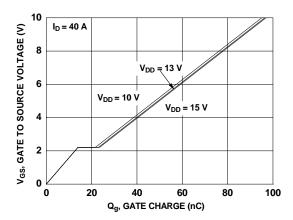


Figure 20. Gate Charge Characteristics

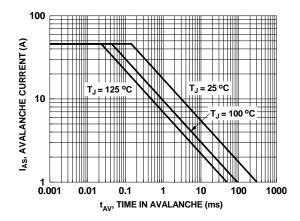


Figure 22. Unclamped Inductive Switching Capability

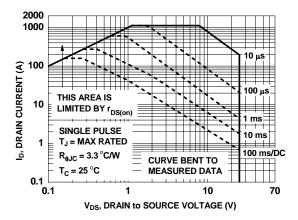


Figure 24. Forward Bias Safe Operating Area

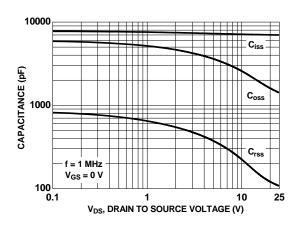


Figure 21. Capacitance vs. Drain to Source Voltage

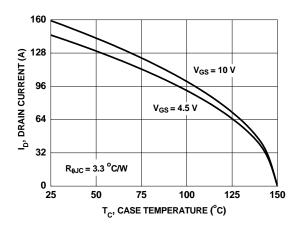


Figure 23. Maximum Continuous Drain Current vs. Case Temperature

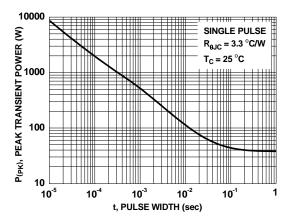


Figure 25. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unless otherwise noted.

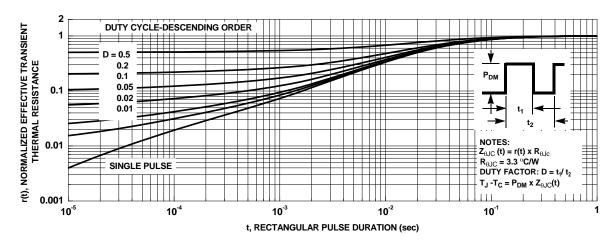


Figure 26. Junction-to-Case Transient Thermal Response Curve

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Typical Characteristics (continued)

SyncFETTM Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench[®] MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverses recovery characteristic of the FDPC8014AS.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

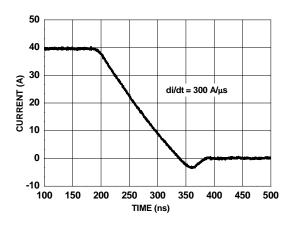


Figure 27. FDPC8014AS SyncFET[™] Body Diode Reverse Recovery Characteristic

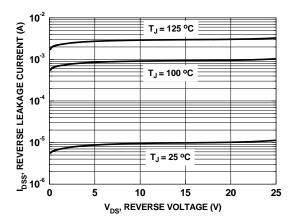
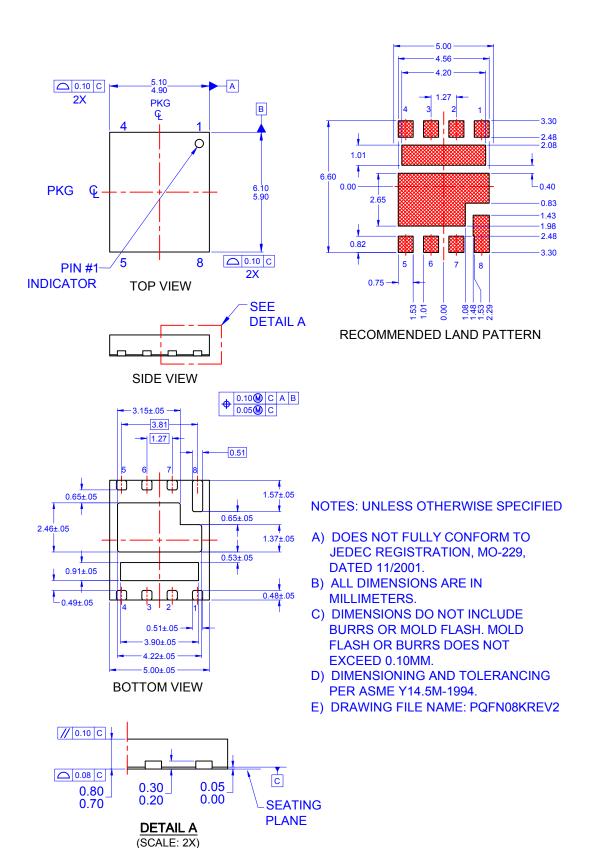


Figure 28. SyncFETTM Body Diode Reverse Leakage vs. Drain-source Voltage



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